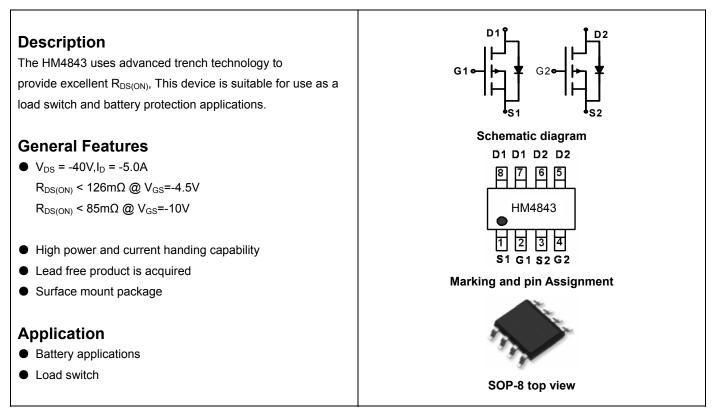


# Dual P-Channel Enhancement Mode Power MOSFET



### Package Marking and Ordering Information

| Device Marking | Device | Device Package | Reel Size | Tape width | Quantity   |
|----------------|--------|----------------|-----------|------------|------------|
| HM4843         | HM4843 | SOP-8          | Ø180mm    | 8 mm       | 3000 units |

#### Absolute Maximum Ratings (T<sub>A</sub>=25<sup>°</sup>Cunless otherwise noted)

| Parameter  | Symbol          | Limit      | Unit |
|--|-----------------|------------|------|
| Drain-Source Voltage                             | Vds             | -40        | V    |
| Gate-Source Voltage                              | Vgs             | ±20        | V    |
| Drain Current-Continuous                         | I <sub>D</sub>  | -5.0       | А    |
| Drain Current-Pulsed (Note 1)                    | I <sub>DM</sub> | -20        | А    |
| Maximum Power Dissipation                        | PD              | 2.0        | W    |
| Operating Junction and Storage Temperature Range | TJ,TSTG         | -55 To 150 | °C   |

#### **Thermal Characteristic**

| Thermal Resistance, Junction-to-Ambient (Note 2)R <sub>0JA</sub> 62.5°C/W |
|---|
|---|

#### Electrical Characteristics (T<sub>A</sub>=25°C unless otherwise noted)

| Parameter                       | Symbol            | Condition                                  | Min | Тур | Max | Unit |
|---------------------------------|-------------------|--|-----|-----|-----|------|
| Off Characteristics             |                   |  |     |     |     |      |
| Drain-Source Breakdown Voltage  | BV <sub>DSS</sub> | V <sub>GS</sub> =0V I <sub>D</sub> =-250µA | -40 | -   | -   | V    |
| Zero Gate Voltage Drain Current | I <sub>DSS</sub>  | $V_{DS}$ =-40V, $V_{GS}$ =0V               | -   | -   | -1  | μA   |



| Parameter                          | Symbol              | Condition   | Min | Тур  | Max  | Unit |
|------------------------------------|---------------------|---|-----|------|------|------|
| Gate-Body Leakage Current          | I <sub>GSS</sub>    | V <sub>GS</sub> =±20V,V <sub>DS</sub> =0V                             | -   | -    | ±100 | nA   |
| On Characteristics (Note 3)        | ·                   |   | •   |      |      |      |
| Gate Threshold Voltage             | V <sub>GS(th)</sub> | V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =-250µA              | -1  | -1.5 | -3   | V    |
| Drain-Source On-State Resistance   | Р                   | V <sub>GS</sub> =-10V, I <sub>D</sub> =-5A -                          |     | 73   | 85   | mΩ   |
| Drain-Source On-State Resistance   | R <sub>DS(ON)</sub> | V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-4A -                         |     | 98   | 126  | mΩ   |
| Forward Transconductance           | <b>g</b> fs         | V <sub>DS</sub> =-5V,I <sub>D</sub> =-4.1A                            |     | -    | -    | S    |
| Dynamic Characteristics (Note4)    |                     | ·   |     |      |      |      |
| Input Capacitance                  | C <sub>lss</sub>    | (1 - 20)(1)(-0)(1)  | -   | 650  | -    | PF   |
| Output Capacitance                 | C <sub>oss</sub>    | V <sub>DS</sub> =-20V,V <sub>GS</sub> =0V,<br>F=1.0MHz                | -   | 90   | -    | PF   |
| Reverse Transfer Capacitance       | C <sub>rss</sub>    | r – 1.000112  | -   | 70   | -    | PF   |
| Switching Characteristics (Note 4) |                     |   |     |      |      |      |
| Turn-on Delay Time                 | t <sub>d(on)</sub>  |   | -   | 9    | -    | nS   |
| Turn-on Rise Time                  | tr                  | $V_{DD}$ =-20V, , $R_L$ =2 $\Omega$                                   | -   | 8    | -    | nS   |
| Turn-Off Delay Time                | t <sub>d(off)</sub> | $V_{GS}$ =-10V,R <sub>GEN</sub> =3 $\Omega$                           | -   | 28   | -    | nS   |
| Turn-Off Fall Time                 | t <sub>f</sub>      |   | -   | 10   | -    | nS   |
| Total Gate Charge                  | Qg                  | V <sub>DS</sub> =-20V,I <sub>D</sub> =-3.1A,                          | -   | 14   | -    | nC   |
| Gate-Source Charge                 | Q <sub>gs</sub>     | V <sub>DS</sub> =-20V,I <sub>D</sub> =-3.1A,<br>V <sub>GS</sub> =-10V | -   | 2.9  | -    | nC   |
| Gate-Drain Charge                  | Q <sub>gd</sub>     | v <sub>GS</sub> 10v   | -   | 3.8  | -    | nC   |
| Drain-Source Diode Characteristics |                     |   |     |      |      |      |
| Diode Forward Voltage (Note 3)     | V <sub>SD</sub>     | V <sub>GS</sub> =0V,I <sub>S</sub> =-2.5A                             | -   | 0.8  | 1.2  | V    |
| Diode Forward Current (Note 2)     | Is                  |   | -   | -    | -5.3 | А    |

#### Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature.

**2.** Surface Mounted on FR4 Board,  $t \le 10$  sec.

**3.** Pulse Test: Pulse Width  $\leq$  300µs, Duty Cycle  $\leq$  2%.

4. Guaranteed by design, not subject to production



# **Typical Electrical and Thermal Characteristics**

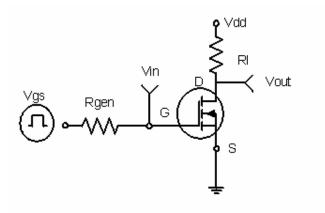


Figure 1:Switching Test Circuit

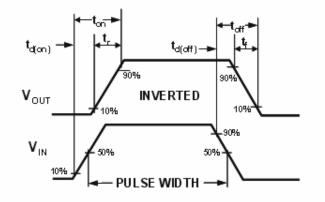
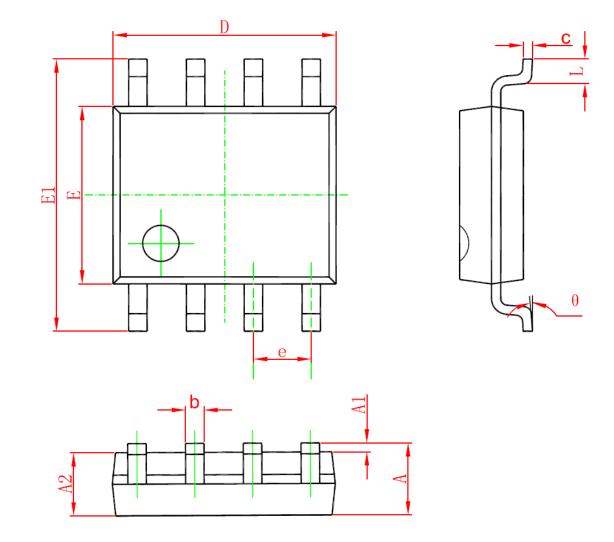


Figure 2:Switching Waveforms



## SOP8 PACKAGE OUTLINE DIMENSIONS



| Cumb a l | Dimensions Ir | n Millimeters | Dimensions In Inches |        |  |
|----------|---------------|---------------|----------------------|--------|--|
| Symbol   | Min           | Max           | Min                  | Max    |  |
| A        | 1.350         | 1. 750        | 0. 053               | 0.069  |  |
| A1       | 0. 100        | 0. 250        | 0.004                | 0.010  |  |
| A2       | 1.350         | 1. 550        | 0. 053               | 0.061  |  |
| b        | 0. 330        | 0. 510        | 0.013                | 0. 020 |  |
| с        | 0. 170        | 0. 250        | 0.006                | 0.010  |  |
| D        | 4. 700        | 5. 100        | 0. 185               | 0. 200 |  |
| E        | 3.800         | 4.000         | 0. 150               | 0. 157 |  |
| E1       | 5.800         | 6. 200        | 0. 228               | 0. 244 |  |
| е        | 1. 270 (BSC)  |               | 0. 050 (BSC)         |        |  |
| L        | 0.400         | 1. 270        | 0.016                | 0.050  |  |
| θ        | 0°            | 8°            | 0°                   | 8°     |  |



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